SPECIFICATION

Device Name : Power MOSFET

Type Name : 2SK3697-01

Spec. No. : MS5F5476

Date : *May.-20-2003*

Fuji Electric Co.,Ltd. Matsumoto Factory

	DATE	NAME	APPROVED		Fuji Electric Co	o I td	
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Revised Records

Date	Classification	Index	Content	Drawn	Checked	Checked	Approved
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1.Scope This specifies Fuji Power MOSFET 2SK3697-012.Construction N-Channel enhancement mode power MOSFET

3.Applications for Switching

4.Outview TO-247 Outview See to 8/19 page

5. Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain Source Voltage	V_{DS}	600	V	
Drain-Source Voltage	V_{DSX}	600	V	V _{GS} =-30V
Continuous Drain Current		<u>+</u> 42	Α	
Continuous Diam Current	I _D	± 2.7	Α	Ta=25°C
Pulsed Drain Current	I _{DP}	± 168	Α	
Gate-Source Voltage	V_{GS}	± 30	V	
Non-Repetitive Maximum Avalanche Current	I _{AS}	42	А	Tch=25°C *1
Repetitive Maximum Avalanche Current	I _{AR}	21	Α	Tch<=150°C *1
Non-Repetitive Maximum Avalanche Energy	E _{AS}	828	mJ	*2
Maximum Drain-Source dV/dt	dV _{DS} /dt	20	kV/μs	VDS<=600V
Peak Diode Recovery dV/dt	dV/dt	5	kV/μs	*3
Peak Diode Recovery -di/dt	-di/dt	100	A/μs	*4
Maximum Dowar Dissination	D	2.50	W	Ta=25°C
Maximum Power Dissipation	P_{D}	600	VV	Tc=25°C
Operating and Storage	T _{ch}	150	°C	
Temperature range	T _{stg}	-55 to +150	°C	

^{*1} See to Avalanche Current Graph (Page 17/19)

6.Electrical Characteristics at Tc=25°C (unless otherwise specified) Static Ratings

Description	Symbol	Conditions		min.	typ.	max.	Unit
Drain-Source		I _D =250μA					
Breakdown Voltage	BV _{DSS}	V _{GS} =0V		600	-	-	V
Gate Threshold		I _D =250μA					
Voltage	V _{GS} (th)	$V_{DS}=V_{GS}$		3.0	-	5.0	V
Zero Gate Voltage		V _{DS} =600V VGS=0V	T _{ch} =25°C	,	10	25	μΑ
Drain Current	I _{DSS}	VDS=480V V _{GS} =0V	T _{ch} =125°C	-	1.0	2.0	mA
Gate-Source		$V_{GS} = \pm 30V$					
Leakage Current	I_{GSS}	V _{DS} =0V		-	10	100	nA
Drain-Source I _D =21A							
On-State Resistance	R _{DS} (on)	V _{GS} =10V		-	0.14	0.17	Ω

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^{*2} L=861μH,Vcc=60V,Starting Tch=25°C, See to Avalanche Energy Graph (Page 18/19)

^{*3} $I_F \le -I_D$,-di/dt=100A/ μ s,Vcc \le BV_{DSS},Tch \le 150°(*4 $I_F \le -I_D$,dV/dt=5kV/ μ s,Vcc \le BV_{DSS},Tch \le 150°C

Dynamic Ratings

Description Symbol Conditions		min.	typ.	max.	Unit	
Forward		I _D =21A				
Transconductance	g _{fs}	V _{DS} =25V	20	40	-	S
Input Capacitance	Ciss	V _{DS} =25V	-	5100	7650	
Output Capacitance	Coss	V _{GS} =0V	-	700	1050	
Reverse Transfer		f=1MHz	-	48	72	pF
Capacitance	Crss					
	td(on)	V _{cc} =300V	-	60	90	
Turn-On Time	tr	V _{GS} =10V	-	90	135	
	td(off)	I _D =21A	-	180	270	ns
Turn-Off Time	tf	R_{GS} =10 Ω	-	30	45	
Total Gate Charge	Q_G	V _{cc} =300V	-	105	160	
Gate-Source Charge	Q_{GS}	I _D =42A	-	44	65	nC
Gate-Drain Charge	Q_{GD}	V _{GS} =10V	-	30	45	

Reverse Diode

Description	Symbol	Conditions	min.	typ.	max.	Unit
Avalanche Capability		L=861μH Tch=25°C				
	I_{AV}	See Fig.1 and Fig.2	42	ı	-	Α
Diode Forward		I _F =42A				
On-Voltage	V_{SD}	V _{GS} =0V T _{ch} =25°C	-	1.20	1.80	٧
Reverse Recovery		I _F =42A				
Time	trr	V _{GS} =0V	-	160	250	ns
Reverse Recovery		-di/dt=100A/μs				
Charge	Qrr	T _{ch} =25°C	-	1.00	2.5	μС

7.Thermal Resistance

Description	Symbol	min.	typ.	max.	Unit
Channel to Case	Rth(ch-c)			0.208	°C/W
Channel to Ambient	Rth(ch-a)			50.0	°C/W

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Fig.1 Test circuit

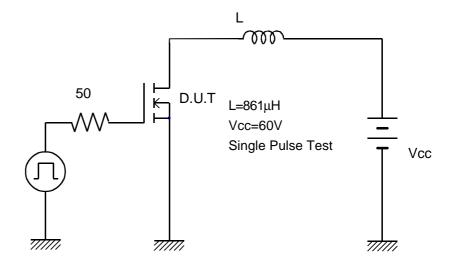
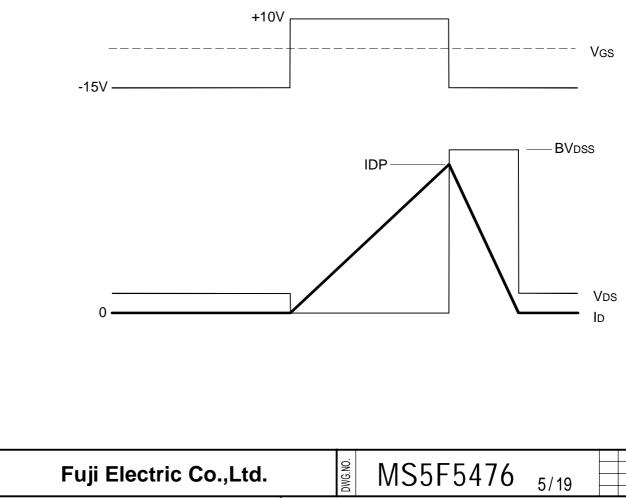


Fig.2 Operating waveforms



All guaranteed values are under the categories of reliability per non-assembled(only MOSFETs). Each categories under the guaranteed reliability conform to EIAJ ED4701 B101A standards.

Test items required without fail: Test Method B-121,B-122,B-123,B-131,B-141 Humidification treatment (85±2°C,65±5%RH,168±24hr)

Heat treatment of soldering (Solder Dipping,260±5°C(265°Cmax.),10±1sec,2 times)

	Test No.	Test Items	Testing methods and Conditions	Reference Standard	Sampling number	Acceptance number
				EIAJ ED4701		
	1	Terminal	Pull force			
		Strength	TO-220,TO-220F: 10N			
		(Tensile)	TO-3P,TO-3PF,TO-247: 25N	A-111A	15	
			TO-3PL: 45N	method 1		
			T-Pack,K-Pack: 10N			
			Force maintaining duration :30±5sec			
	2	Terminal	Load force			
		Strength	TO-220,TO-220F: 5N			
		(Bending)	TO-3P,TO-3PF,TO-247: 10N	A-111A	15	
			TO-3PL : 15N	method 3		
<u>s</u>			T-Pack,K-Pack: 5N			
ĕ			Number of times :2times(90deg./time)			
Mechanical test methods	3	Mounting	Screwing torque value: (M3)			(0:1)
<u> </u>		Strength	TO-220,TO-220F: 40±10Ncm	A-112	15	
l es			TO-3P,TO-3PF,TO-247: 50±10Ncm	method 2		
g			TO-3PL: 70±10Ncm			
l jū	4	Vibration	frequency: 100Hz to 2kHz			
<u>ដ</u>			Acceleration: 100m/s ²	A-121	15	
Ме			Sweeping time: 20min./1 cycle	test code C		
_			6times for each X,Y&Z directions.			
	5	Shock	Peak amplitude: 15km/s ²	A-122		
			Duration time: 0.5ms	test code D	15	
			3times for each X,Y&Z directions.			
	6	Solderability	Solder temp. : 235±5°C			
			Immersion time: 5±0.5sec	A-131A		
			Each terminal shall be immersed in	test code A	15	
			the solder bath within 1 to 1.5mm from			
			the body.			
	7	Resistance to	Solder temp. : 260±5°C			
		Soldering Heat	Immersion time: 10±1sec	A-132	15	
			Number of times : 2times			

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	Test No.	Test Items	Testing methods and Conditions	Reference Standard EIAJ ED4701	Sampling number	Acceptance number
	1	High Temp. Storage	Temperature : 150+0/-5°C Test duration : 1000hr	B-111A	22	
	2	Low Temp. Storage	Temperature : -55+5/-0°C Test duration : 1000hr	B-112A	22	
	3	Temperature Humidity Storage	Temperature: 85±2°C Relative humidity: 85±5% Test duration: 1000hr	B-121A test code C	22	
nethods	4	Temperature Humidity BIAS	Temperature: 85±2°C Relative humidity: 85±5% Bias Voltage: V _{DS} (max) * 0.8 Test duration: 1000hr	B-122A test code C	22	
Climatic test methods	5	Unsaturated Pressurized Vapor	Temperature : 130±2°C Relative humidity : 85±5% Vapor pressure : 230kPa Test duration : 48hr	B-123A test code C	22	(0:1)
ō	6	Temperature Cycle	High temp.side: 150±5°C Low temp.side: -55±5°C Duration time: HT 30min,LT 30min Number of cycles: 100cycles	B-131A test code A	22	
	7	Thermal Shock	Fluid: pure water(running water) High temp.side: 100+0/-5°C Low temp.side: 0+5/-0°C Duration time: HT 5min,LT 5min Number of cycles: 100cycles	B-141A test code A	22	
Ξ	1	Intermittent Operating Life	Ta=25±5°C ΔTc=90degree Tch≤Tch(max.) Test duration : 3000 cycle	D-322	22	
Test for FET	2	HTRB (Gate-source)	Temperature: Tch=150+0/-5°C Bias Voltage: V _{GS} (max) Test duration: 1000hr	D-323	22	(0:1)
-	3	HTRB (Drain-Source)	Temperature: Tch=150+0/-5°C Bias Voltage: V _{DS} (max) * 0.8 Test duration: 1000hr	D-323	22	

Failure Criteria

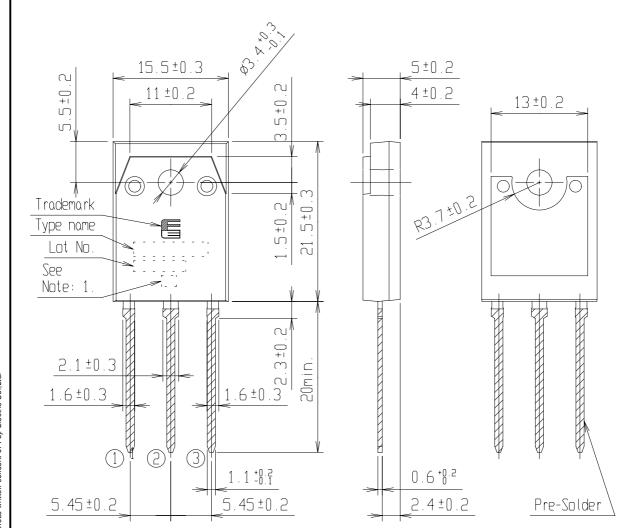
		Symbols	Failure	Criteria	Unit
	Item		Lower Limit	Upper Limit	
	Breakdown Voltage	BVDSS	LSL * 1.0		V
S	Zero gate Voltage Drain-Source Current	IDSS		USL * 2	Α
cal	Gate-Source Leakage Current	IGSS		USL * 2	Α
Electrical Characterist	Gate Threshold Voltage	VGS(th)	LSL * 0.8	USL * 1.2	V
Ele	Drain-Source on-state Resistance	RDS(on)		USL * 1.2	Ω
5	Forward Transconductance	gfs	LSL * 0.8		S
	Diode forward on-Voltage	VSD		USL * 1.2	V
ΘW	Marking				
Outview	Soldering		With eyes or Micr	oscope	
ŏ	and other damages				

^{*} LSL: Lower Specification Limit

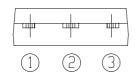
^{*} USL : Upper Specification Limit

^{*} Before any of electrical characteristics measure, all testing related to the humidity have conducted after drying the package surface for more than an hour at 150°C.

FUJI POWER MOS FET



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CONNECTION

- ① GATE
- 2 DRAIN
- 3 SOURCE

JEDEC: TO-247

Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

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9. Cautions

- · Although Fuji Electric is continually improving product quality and reliability, a small percentage of semiconductor products may become faulty. When using Fuji Electric semiconductor products in your equipment, you are requested to take adequate safety measures to prevent the equipment from causing physical injury, fire, or other problem in case any of the products fail. It is recommended to make your design fail-safe, flame retardant, and free of malfunction.
- The products described in this Specification are intended for use in the following electronic and electrical equipment which has normal reliability requirements.

Computers

· OA equipment

· Communications equipment(Terminal devices)

· Machine tools

· AV equipment

· Measurement equipment

· Personal equipment

Industrial robots

- · Electrical home appliances etc.
- The products described in this Specification are not designed or manufactured to be used in equipment or systems used under life-threatening situations. If you are considering using these products in the equipment listed below, first check the system construction and required reliability, and take adequate safety measures such as a backup system to prevent the equipment from malfunctioning.
 - · Backbone network equipment
- · Transportation equipment (automobiles, trains, ships, etc.)
- · Traffic-signal control equipment
- · Gas alarms, leakage gas auto breakers
- · Submarine repeater equipment
- · Burglar alarms, fire alarms, emergency equipment

Medical equipment

- Nuclear control equipment etc.
- · Do not use the products in this Specification for equipment requiring strict reliability such as(but not limited to):
 - · Aerospace equipment
- · Aeronautical equipment

10. Warnings

- The MOSFETs should be used in products within their absolute maximum rating(voltage, current, temperature, etc.).
- The MOSFETs may be destroyed if used beyond the rating.
- · We only guarantee the non-repetitive and repetitive Avalanche capability and not for the continuous Avalanche capability which can be assumed as abnormal condition .Please note the device may be destructed from the Avalanche over the specified maximum rating.
- The equipment containing MOSFETs should have adequate fuses or circuit breakers to prevent the equipment from causing secondary destruction.
- Use the MOSFETs within their reliability and lifetime under certain environments or conditions. The MOSFETs may fail before the target lifetime of your products if used under certain reliability conditions.
- · You must careful handling of MOSFETs for ESD damage is an important consideration.
- · When handling MOSFETs, hold them by the case (package) and don't touch the leads and terminals.
- · It is recommended that any handling of MOSFETs is done while used electrically conductive floor and tablemats that are grounded.

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- Before touching a MOSFETs terminal, discharge any static electricity from your body and clothes by grounding out through a high impedance resistor (about $1M\Omega$)
- · When soldering, in order to protect the MOSFETs from static electricity, ground the soldering iron or soldering bath through a low impedance resistor.
- · You must design the MOSFETs to be operated within the specified maximum ratings(voltage, current, temperature, etc.) to prevent possible failure or destruction of devices.
- · Consider the possible temperature rise not only for the channel and case, but also for the outer leads.
- · Do not directly touch the leads or package of the MOSFETs while power is supplied or during operation ,to avoid electric shock and burns.
- The MOSFETs are made of incombustible material. However, if a MOSFET fails, it may emit smoke of flame. Also, operating the MOSFETs near any flammable place or material may cause the MOSFETs to emit smoke or flame in case the MOSFETs become even hotter during operation. Design the arrangement to prevent the spread of fire.
- The MOSFETs should not used in an environment in the presence of acid, organic matter, or corrosive gas(hydrogen sulfide, sulfurous acid gas etc.)
- · The MOSFETs should not used in an irradiated field since they are not radiation-proof.

Installation

· Soldering involves temperatures which exceed the device storage temperature rating. To avoid device damage and to ensure reliability, observe the following guidelines from the quality assurance standard.

Solder temperature and duration (through-hole package)

Solder temperature	Duration
260±5 °C	10±1 seconds
350±10 °C	3.5±0.5 seconds

- The immersion depth of the lead should basically be up to the lead stopper and the distance should be a maximum of 1.5mm from the device.
- · When flow-soldering, take care to avoid immersing the package in the solder bath.
- Refer to the following torque reference When mounting the device on a heat sink. Excess torque applied to the
 mounting screw causes damage to the device and weak torque will increase the thermal resistance, both of
 which conditions may destroy the device.

Table 1: Recommended tightening torques.

Package style	Screw	Tightening torques	Note
TO-220	M3	30 – 50 Ncm	
TO-220F	IVIS	30 – 50 NCIII	flatness: < ±30µm
TO-3P			roughness: <10μm
TO-3PF	M3	40 – 60 Ncm	Plane off the edges:
TO-247			C<1.0mm
TO-3PL	M3	60 –80 Ncm	

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- The heat sink should have a flatness within±30μm and roughness within 10μm. Also, keep the tightening torque within the limits of this specification.
- \cdot Improper handling may cause isolation breakdown leading to a critical accident.
- ex.) Over plane off the edges of screw hole. (We recommend plane off the edge is C<1.0mm)
- · We recommend the use of thermal compound to optimize the efficiency of heat radiation. It is important to evenly apply the compound and to eliminate any air voids.

Storage

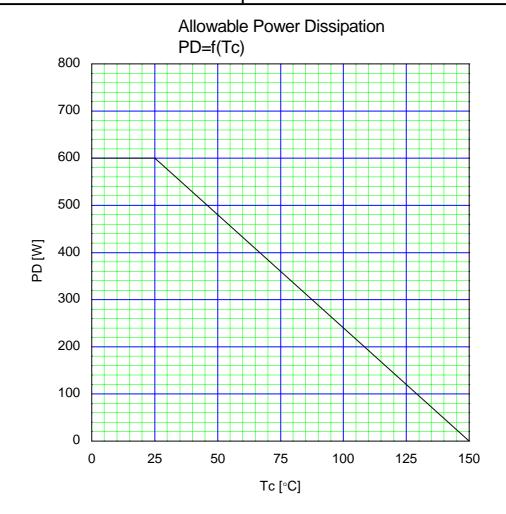
- The MOSFETs must be stored at a standard temperature of 5 to 35°C and relative humidity of 45 to 75%.
- · If the storage area is very dry, a humidifier may be required. In such a case, use only deionized water or boiled water, since the chlorine in tap water may corrode the leads.
- The MOSFETs should not be subjected to rapid changes in temperature to avoid condensation on the surface of the MOSFETs. Therefore store the MOSFETs in a place where the temperature is steady.
- · The MOSFETs should not be stored on top of each other, since this may cause excessive external force on the case.
- The MOSFETs should be stored with the lead terminals remaining unprocessed. Rust may cause presoldered connections to go fail during later processing.
- · The MOSFETs should be stored in antistatic containers or shipping bags.

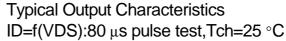
11.Appendix

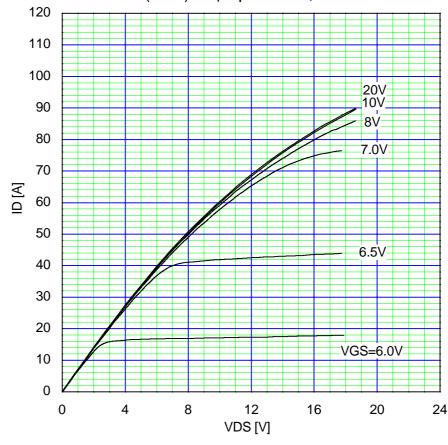
- · These products do not contain PBBs (Polybrominated Biphenyl) or PBDEs (Polybrominated Diphenyl Ether).
- · These products do not contain Class-I ODS and Class-II ODS of 'Clean Air Act of US'.
 - If you have any questions about any part of this Specification, please contact Fuji Electric or its sales agent before using the product.
 - Neither Fuji nor its agents shall be held liable for any injury caused by using the products not in accordance with the instructions.
 - The application examples described in this specification are merely typical uses of Fuji Electric products.
 - This specification does not confer any industrial property rights or other rights, nor constitute a license for such rights.

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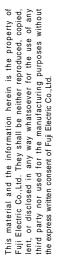


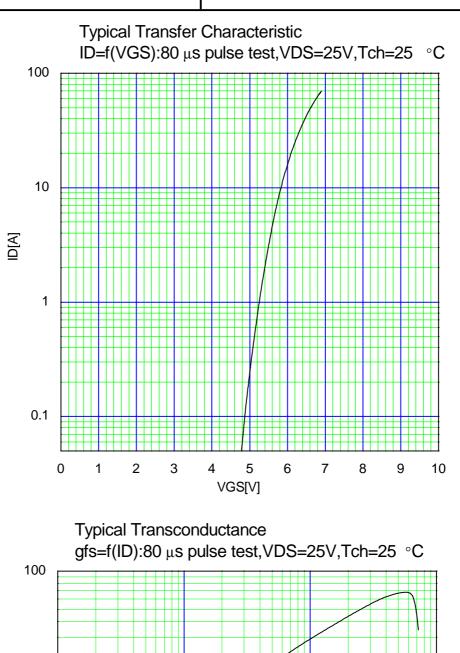


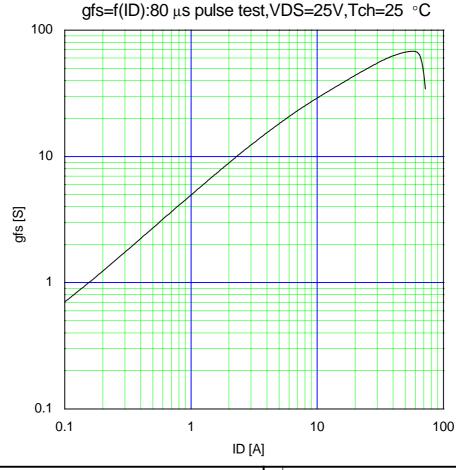


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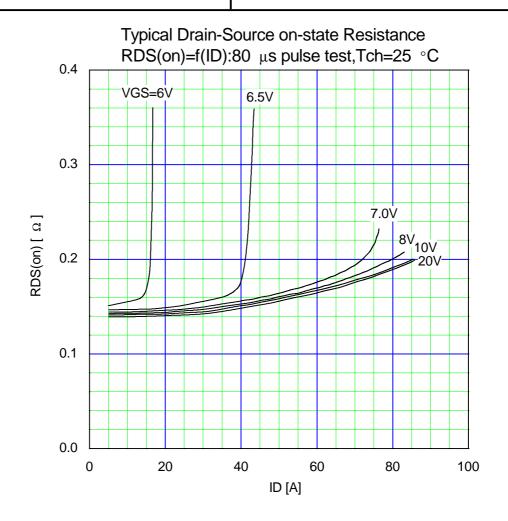


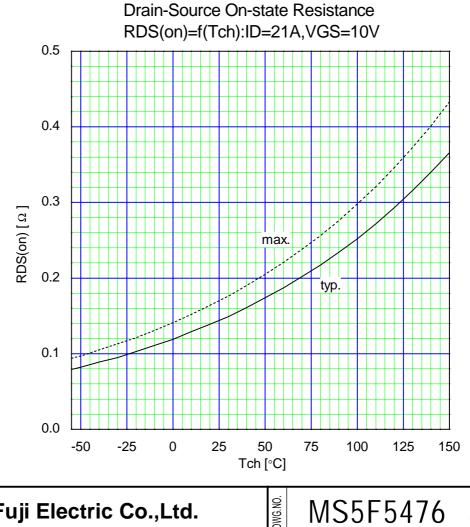




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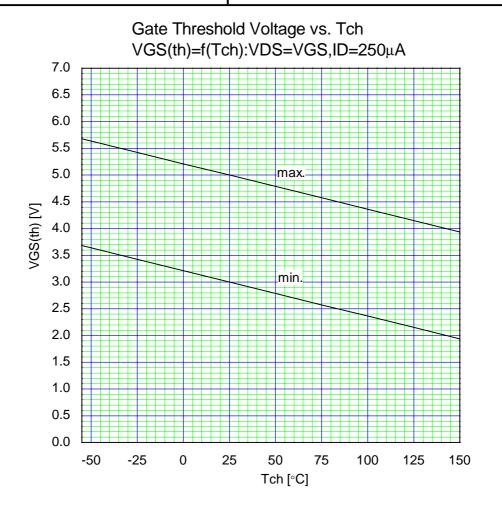
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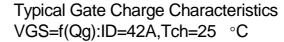


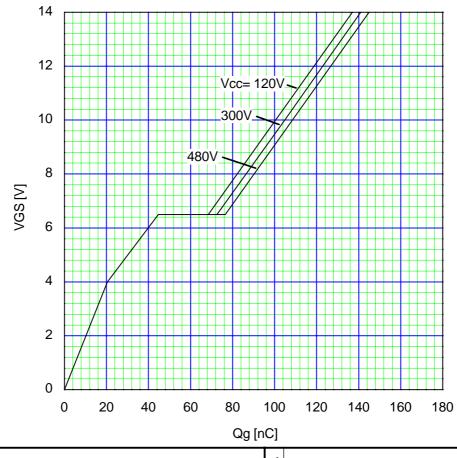


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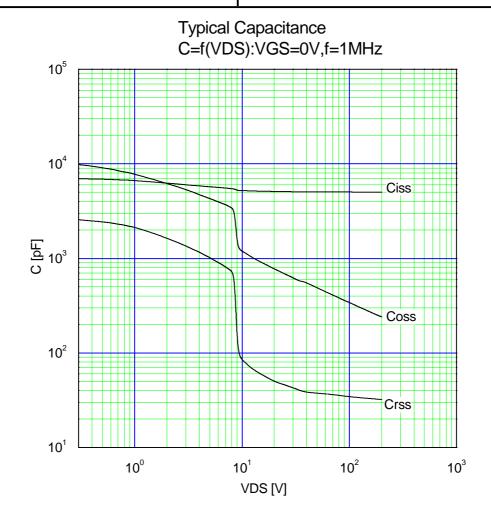




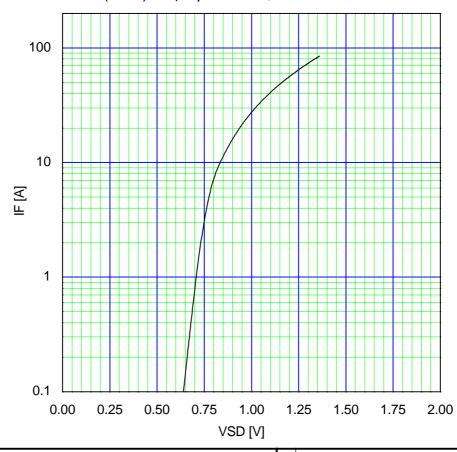


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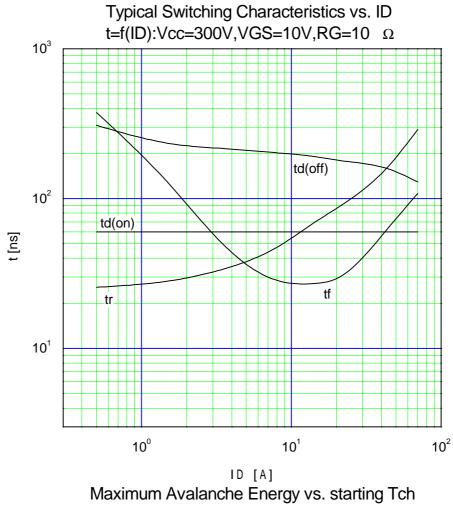


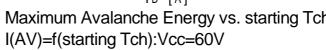
Typical Forward Characteristics of Reverse Diode IF=f(VSD):80 μs pulse test,Tch=25 °C

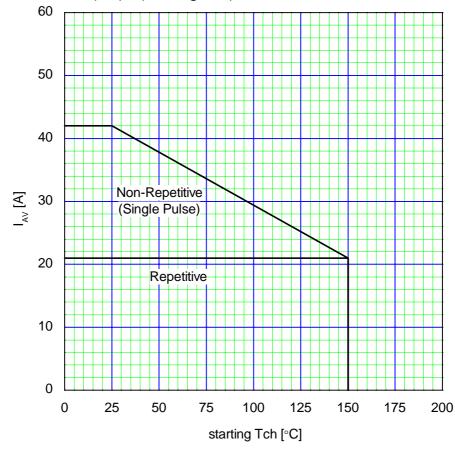


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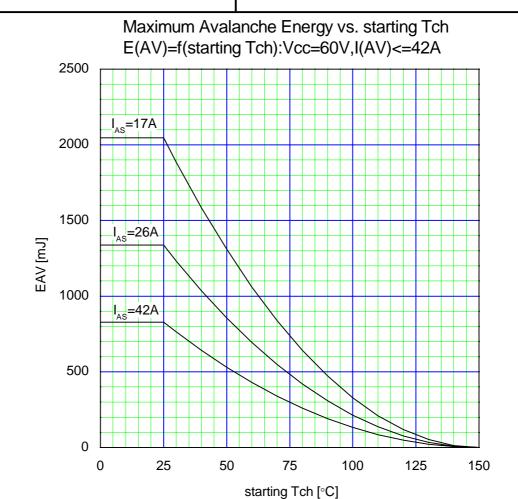


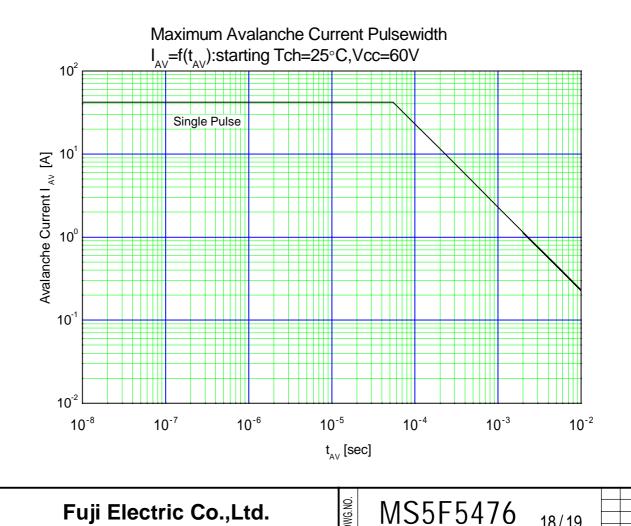


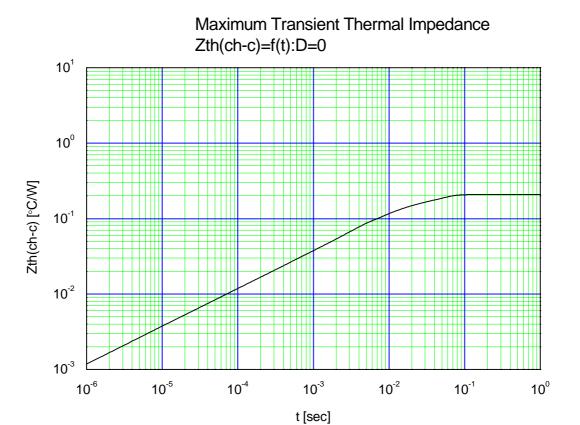


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